



High Speed Dual D Type Master Slave Flip-Flop

ELECTRICALLY TESTED PER:
MIL-M-38510/06102

The 10631 is a dual master-slave type D flip-flop. Asynchronous Set (S) and Reset (R) override Clock (C_C) and Clock Enable (C_E) inputs. Each flip-flop may be clocked separately by holding the common clock in the low state and using the enable inputs for the clocking function. If the common clock is to be used to clock the flip-flop, the Clock Enable inputs must be in the low state. In this case, the enable inputs perform the function of controlling the common clock.

The output states of the flip-flop change on the positive transition of the clock. A change in the information present at the data (D) input will not affect the output information at any other time due to master slave construction.

- 375 mW Max/Pkg (No Load)
- $t_{\text{tog}} = 225 \text{ MHz typ}$
- $t_{\text{pd}} = 2.0 \text{ ns typ}$ (All Output Loaded)
- $t_r, t_f = 2.0 \text{ ns typ}$ (20% - 80%)

PIN ASSIGNMENTS

FUNCTION	DIL	FLATS	LCC	BURN-IN (CONDITION C)
V _{CC1}	1	5	2	GND
Q ₁	2	6	3	51 Ω to V _{TT}
$\overline{Q}_1$	3	7	4	51 Ω to V _{TT}
R ₁	4	8	5	51 Ω to V _{TT}
S ₁	5	9	7	GND
$\overline{C}_{E1}$	6	10	8	OPEN
D ₁	7	11	9	OPEN
V _{EE}	8	12	10	V _{EE}
C _C	9	13	12	OPEN
D ₂	10	14	13	OPEN
$\overline{C}_{E2}$	11	15	14	OPEN
S ₂	12	16	15	GND
R ₂	13	1	17	51 Ω to V _{TT}
$\overline{Q}_2$	14	2	18	51 Ω to V _{TT}
Q ₂	15	3	19	51 Ω to V _{TT}
V _{CC2}	16	4	20	GND

BURN - IN CONDITIONS:

V_{TT} = - 2.0 V MAX/ - 2.2 V MIN

V_{EE} = - 5.7 V MAX/ - 5.2 V MIN

Military 10631

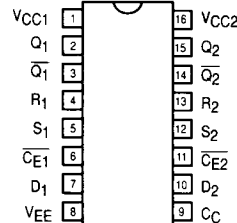


AVAILABLE AS:

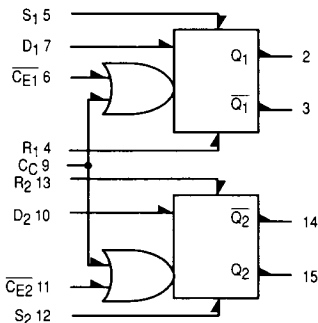
- 1) JAN: JM 38510/06102
 - 2) SMD: N/A
 - 3) 883: 10631/BXAJC
- X = CASE OUTLINE AS FOLLOWS:

PACKAGE: Cerdip: E
CERFLAT: F
LCC: 2

The letter "M" appears before
the slash on LCC.

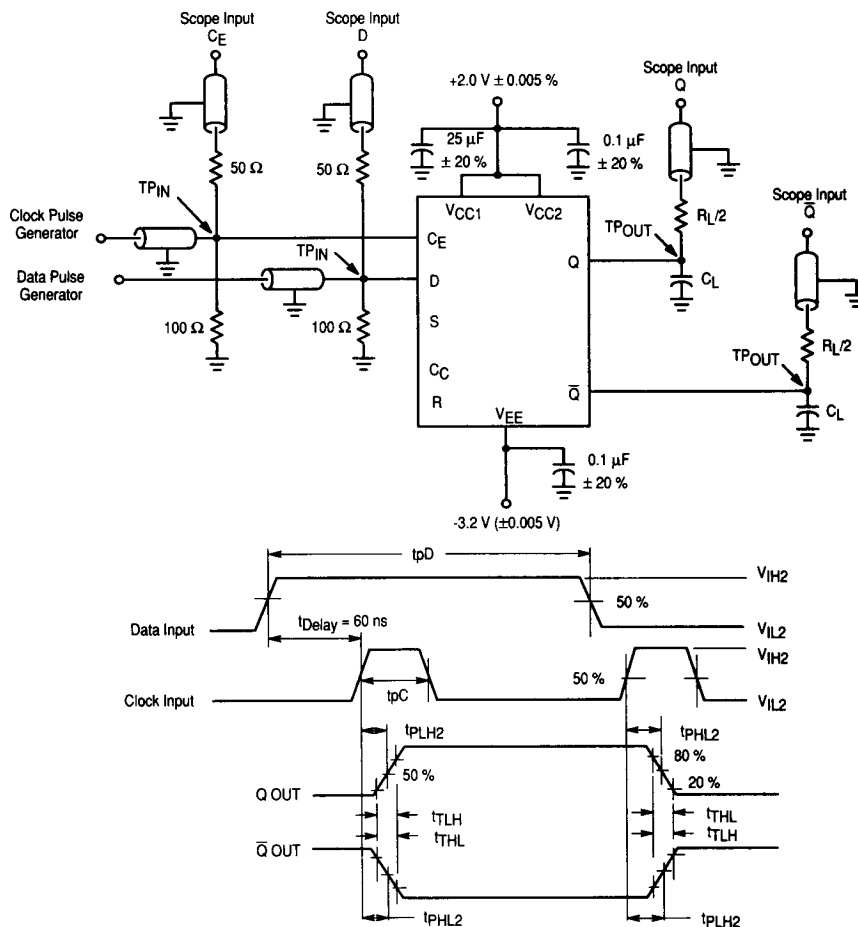


LOGIC DIAGRAM





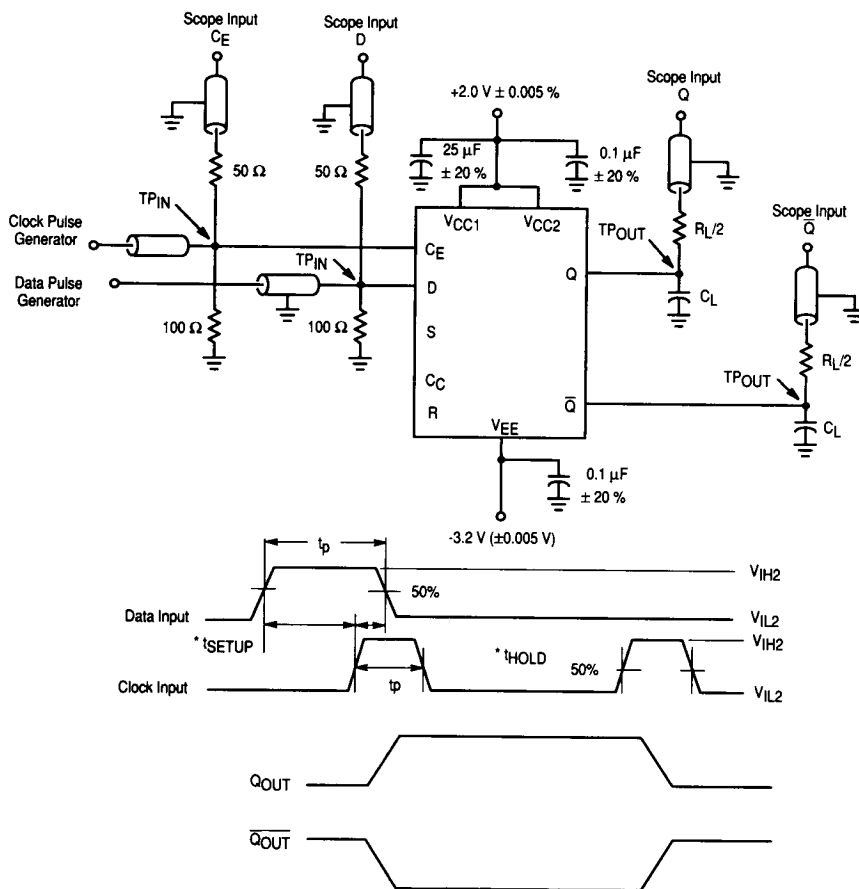
- Figure 2. Set and Reset Switching Test Circuit**



NOTES

1. Perform test in accordance with test table: each output is tested separately.
2. All input and output cables are equal lengths of 50 Ω coaxial cables. Wire length should be ≤ 0.250 (6.35 mm) from tp in to input pin and tp out to output pin.
3. Outputs not under test should be connected to a 100 Ω resistor to ground.
4. Note that observed pulse amplitude is attenuated by one half.
5. $R_L/2 = 50 \Omega \pm 5.0\%$.
6. $Z_{OUT} = 50 \Omega$.
7. $t_{pD}(\text{Data}) = 150 \text{ ns}$, $t_{pC}(\text{Clock}) = 40 \text{ ns}$.
8. $\text{PRR} = 1.0 \text{ MHz}$.
9. Scope Input = 50 Ω to GND.
10. C_L (test Jig) $\leq 5.0 \text{ pF}$.

Figure 3. Synchronous Switching Test Circuit and Waveform

**NOTES**

1. Perform test in accordance with test table: each output is tested separately.
2. All input and output cables are equal lengths of 50 Ω coaxial cables. Wire length should be ≤ 0.250 (6.36 mm) from tp in to input pin and tp out to output pin.
3. Outputs not under test should be connected to a 100 Ω resistor to ground.
4. Note that observed pulse amplitude is attenuated by one half.
5. $R_{L/2} = 50 \Omega \pm 5.0\%$.
6. $Z_{OUT} = 50 \Omega$.
7. $t_p(\text{Data \& Clock}) = 40 \text{ ns}$.
8. Scope Input = 50 Ω to GND.
9. C_L (test Jig) $\leq 5.0 \text{ pF}$.
- * 10. For information only; not tested: $t_{\text{setup}} \geq 1.0 \text{ ns}$, $t_{\text{hold}} \geq 0.75 \text{ ns}$.

Figure 4. Setup and Hold Test Circuit and Waveform

10631

QUIESCENT LIMIT TABLE *

* ELECTRICAL CHARACTERISTICS

Each MECL 10K series circuit has been designed to meet the dc specifications shown in the test table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 linear fpm is maintained. Outputs are terminated through a 100 Ω resistor to - 2.0 volts.

Test Temperature	Test Voltage Values (Volts)							
	V _{IH1}	V _{IL1}	V _{IH2}	V _{IL2}	V _{ITL}	V _{ITH}	V _{EE}	V _{EE1}
T _A = 25 °C	- 0.78	- 1.85	+ 1.11	+ 0.31	- 1.105	- 1.475	- 5.2	- 3.2
T _A = 125 °C	- 0.63	- 1.82	+ 1.24	+ 0.36	- 1.000	- 1.400	- 5.2	- 3.2
T _A = - 55 °C	- 0.88	- 1.92	+ 1.01	+ 0.28	- 1.255	- 1.510	- 5.2	- 3.2

Symbol	Parameter	Limits								Units	TEST VOLTAGE APPLIED TO PINS BELOW													
		+ 25 °C				+ 125 °C					- 55 °C				Pinouts referenced are for DIL package, check Pin Assignments V _{CC} = 0 V, Output Load = 100 Ω to - 2.0 V									
		Subgroup 1		Subgroup 2		Subgroup 3																		
		Min	Max	Min	Max	Min	Max		V _{IH1}	V _{IL1}	V _{IH2}	V _{IL2}	V _{EE}	V _{CC}		P. U. T.								
V _{OH}	High Output Voltage	-0.93	-0.78	-0.825	-0.63	-1.08	-0.88	V	4, 5, 12, 13	4 - 7, 9 - 13			8	1, 16		2, 3, 14, 15								
V _{OL}	Low Output Voltage	-1.85	-1.62	-1.82	-1.545	-1.92	-1.655	V	4, 5, 12, 13	4 - 7, 9 - 13			8	1, 16		2, 3, 14, 15								
V _{OH1}	High Output Voltage	-0.95		-0.845		-1.10		V	4, 5, 12, 13	4 - 7, 9 - 13	4 - 7, 9 - 13	4 - 7, 9 - 13	8	1, 16		2, 3, 14, 15								
V _{OL1}	Low Output Voltage		-1.60		-1.525		-1.635	V	4, 5, 12, 13	4 - 7, 9 - 13	4 - 7, 9 - 13	4 - 7, 9 - 13	8	1, 16		2, 3, 14, 15								
I _{EE}	Power Supply Drain Current	-65		-72		-72		mA					8	1, 16		8								
I _{IH}	Input Current High		220		375		375	μA	6, 11				8	1, 16		6, 11								
I _{IH1}	Input Current High		410		700		700	μA	4, 5, 12, 13				8	1, 16		4, 5, 12, 13								
I _{IH2}	Input Current High		220		375		375	μA	7, 10				8	1, 16		7, 10								
I _{IH3}	Input Current High		290		495		495	μA	9				8	1, 16		9								
I _{IL}	Input Current Low	0.5		0.3		0.5		μA		4 - 7, 9 - 13			8	1, 16		4 - 7, 9 - 13								

10631 QUIESCENT LIMIT TABLE *

* ELECTRICAL CHARACTERISTICS

Each MECL 10K series circuit has been designed to meet the dc specifications shown in the test table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 linear fpm is maintained. Outputs are terminated through a 100 Ω resistor to - 2.0 volts.

Test Temperature	Test Voltage Values (Volts)						
	V _{IH1}	V _{IL1}	V _{IH2}	V _{IL2}	V _{TIL}	V _{ITH}	V _{EE1}
T _A = 25 °C	- 0.78	- 1.85	+ 1.11	+ 0.31	- 1.105	- 1.475	- 5.2
T _A = 125 °C	- 0.63	- 1.82	+ 1.24	+ 0.36	- 1.000	- 1.400	- 5.2
T _A = - 55 °C	- 0.88	- 1.92	+ 1.01	+ 0.28	- 1.255	- 1.510	- 5.2

Symbol	Parameter	Limits						Units	TEST VOLTAGE APPLIED TO PINS BELOW					
	Functional Parameters:	+ 25 °C		+ 125 °C		- 55 °C			Pinouts referenced are for DIL package, check Pin Assignments V _{CC} = 2.0 V, Output Load = 100 Ω to GND					
		Subgroup 9		Subgroup 10		Subgroup 11								
		Min	Max	Min	Max	Min	Max							
t _{TLH}	Rise Time	1.0	3.1	1.1	3.6	0.9	3.4	ns	V _{IN}	V _{OUT}	V _{CC}	V _{EE1}	P. U. T.	
t _{THL}	Fall Time	1.0	3.1	1.1	3.6	0.9	3.4	ns	4 - 7, 10 - 13	2, 3, 14, 15	1, 6	8	2, 3, 14, 15	
t _{PLH1}	Propagation Delay	1.1	3.3	1.0	3.9	1.0	3.7	ns	4 - 7, 10 - 13	2, 3, 14, 15	1, 16	8	2, 3, 14, 15	
t _{PLH2}	Propagation Delay	1.5	3.3	1.2	3.9	1.3	3.7	ns	4 - 7, 10 - 13	2, 3, 14, 15	1, 16	8	2, 3, 14, 15	
t _{PHL1}	Propagation Delay	1.1	3.3	1.0	3.9	1.0	3.7	ns	4 - 7, 10 - 13	2, 3, 14, 15	1, 16	8	2, 3, 14, 15	
t _{PHL2}	Propagation Delay	1.5	3.3	1.2	3.9	1.3	3.7	ns	4 - 7, 10 - 13	2, 3, 14, 15	1, 16	8	2, 3, 14, 15	
f _(max)	Toggle Frequency (max)	200		200		200		MHz	6, 11	2, 15	1, 16	8	2, 3, 14, 15	